

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/713,594	KARR ET AL.	
Examiner	Art Unit	
Duc M. Nguyen	2685	

	SEARCHED		
Class	Subclass	Date	Examiner
455	550 552.1 553.1		
	41.1 41.2		
	41.3 102		
	108 110		
	561		
370	203 204		
	319->321		
	464		
714	746		
	786 798		
375	295		
	298 300		
	302 219		/
	223	3/1/06	pm

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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